





Test Report

IES LM-80-15 Approved Method for Measuring Lumen Maintenance of LED Light Sources

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<p>Test Personal Name & Signatory</p>	<p>Approval Name & Signatory</p>

The above test report is the accredited test result by Korea Laboratory Accreditation Scheme, which signed the ILAC-MRA.

※ If you need confirmation about the authenticity of the test report, please contact the above contact information.

SAMSUNG ELECTRONICS LED BUSINESS
 Accredited by KOLAS, Republic of KOREA

■ Test Report Information ■

1. This test report complies with KS Q ISO/IEC 17025 and KOLAS accreditation regulations.
2. This test report does not comply with KS Q ISO/IEC 17025 and KOLAS accreditation regulations.
3. The test results are limited to samples provided by the client and cannot be partially replicated without the approval of this authority, except as a whole.
4. If a statement of conformity is provided in this report, the applied decision rule does not apply the measurement uncertainty except for the case where the measurement uncertainty is mentioned in the above test method.
5. The test results marked © are not accredited by KOLAS.
6. The test results received from external providers for the test results marked ○.

■ Revision History ■

Date	Revision History	Writer	
		Drawn	Approved
2020.06.17	Rev.0 : New Version	K.Y.KWAK	D.S.PARK

■ Test Summary ■

Life test condition			Summary of result		
Test condition	Current (mA)	Case temperature (°C)	Test duration (h)	Average lumen maintenance (%)	Maximum chromaticity shift ($\Delta u'v'$)
1	150	55.1	10 000	97.0	0.001 6
2	150	85.0	10 000	96.4	0.002 0
3	150	105.0	10 000	93.3	0.004 2

1. Number of the sample

- 20 Packages tested at actual case temperature 55.1 °C
- 20 Packages tested at actual case temperature 85.0 °C
- 20 Packages tested at actual case temperature 105.0 °C

※ Sampling method : Minimum three manufacturing lots with each manufacturing lot built from different wafer lots built on non-consecutive days.

2. Description of LED light sources

- Tested model code : SPMWH3326FP3GAV0S0
- Product series : LM302Z+ (SPMWH*326FP*****)
- Sample manufacturer : Samsung Electronics
- Sample Type : LED Package
- Package dimension : (3.0 × 3.0) mm
- Minimum die spacing : 0.2 mm
- CCT / CRI (Nominal) : 3 000 K / 70

3. Location of Test

- Permanent Testing Lab On Site Testing

(Address : 1, Samsung-ro, Giheung-gu, Yongin-si, Gyeonggi-do 17113, Korea)

4. Description of auxiliary equipment and Operating time

- 1) Instrument Integrating sphere ISP1000-100
- 2) Instrument CAS140-CT
- 3) Keithley 2425 Sourcemeter
- 4) Electrical condition

- Drive current : 150 mA
- Typical voltage : 6.07 V
- Total input power : 0.91 W
- Average current density per LED die : 402 mA/mm²
- Average power density per LED die : 1.22 W/mm²

* LED packages are driven with a constant direct current.

- 5) Test duration : 10 000 h

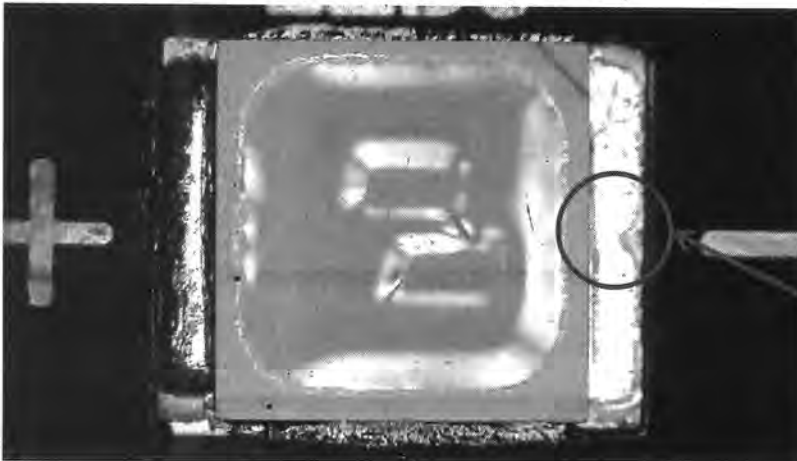
5. Ambient conditions including airflow, temperature and relative humidity

The minimal airflow is maintained in chamber.

The ambient temperature around the LED packages inside chamber is controlled by air flowing and the thermocouple readings are monitored.

- Case temperature : Controlled to $-2\text{ }^{\circ}\text{C}$
- Surrounding air temperature : Controlled to $-5\text{ }^{\circ}\text{C}$
- Relative humidity : $< 65\%$ R.H.

6. Case temperature (Test point temperature)



Case Temperature
Measurement Point

7. Drive current of the LED light source during lifetime test

See Sub-clause 9.1, 9.2 and 9.3

8. Initial luminous flux and forward voltage

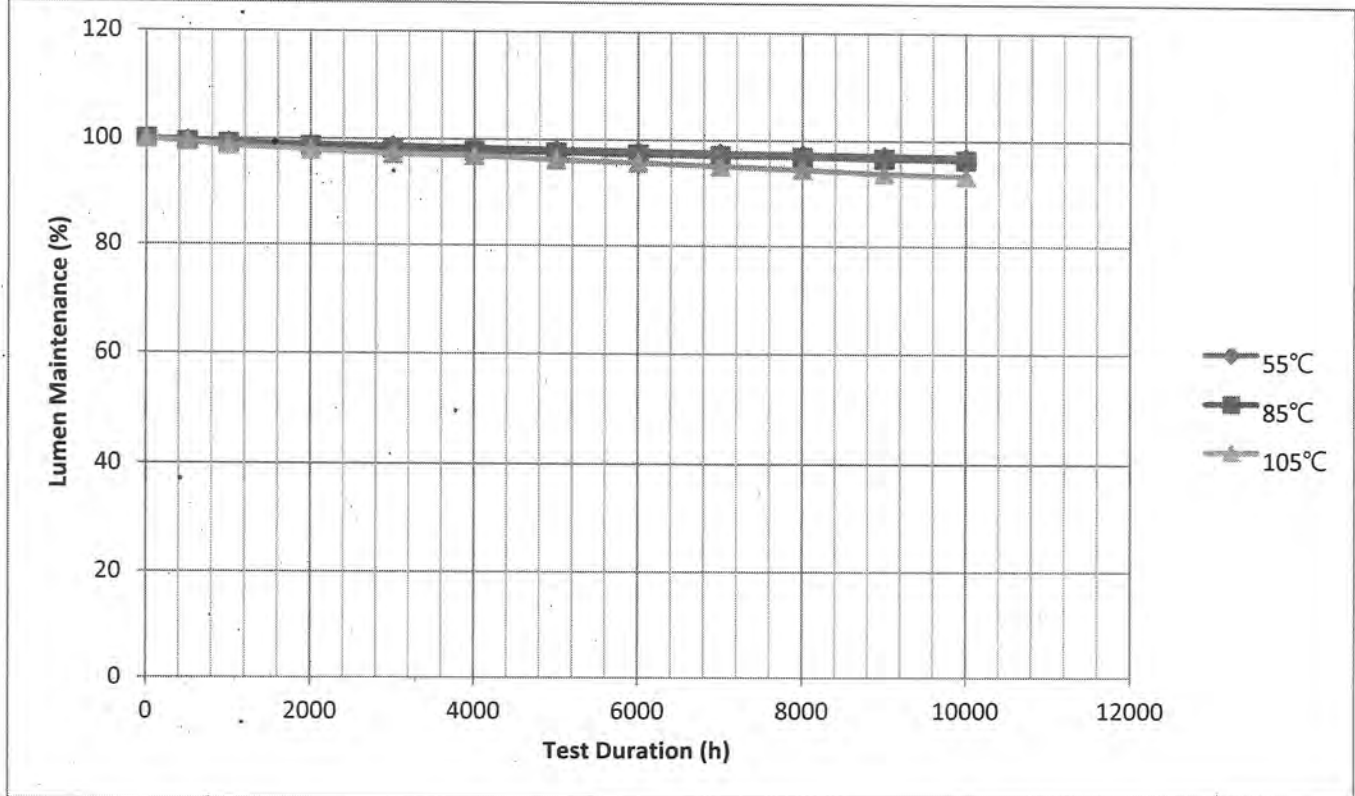
See the table

9. Lumen maintenance data for each individual LED light source

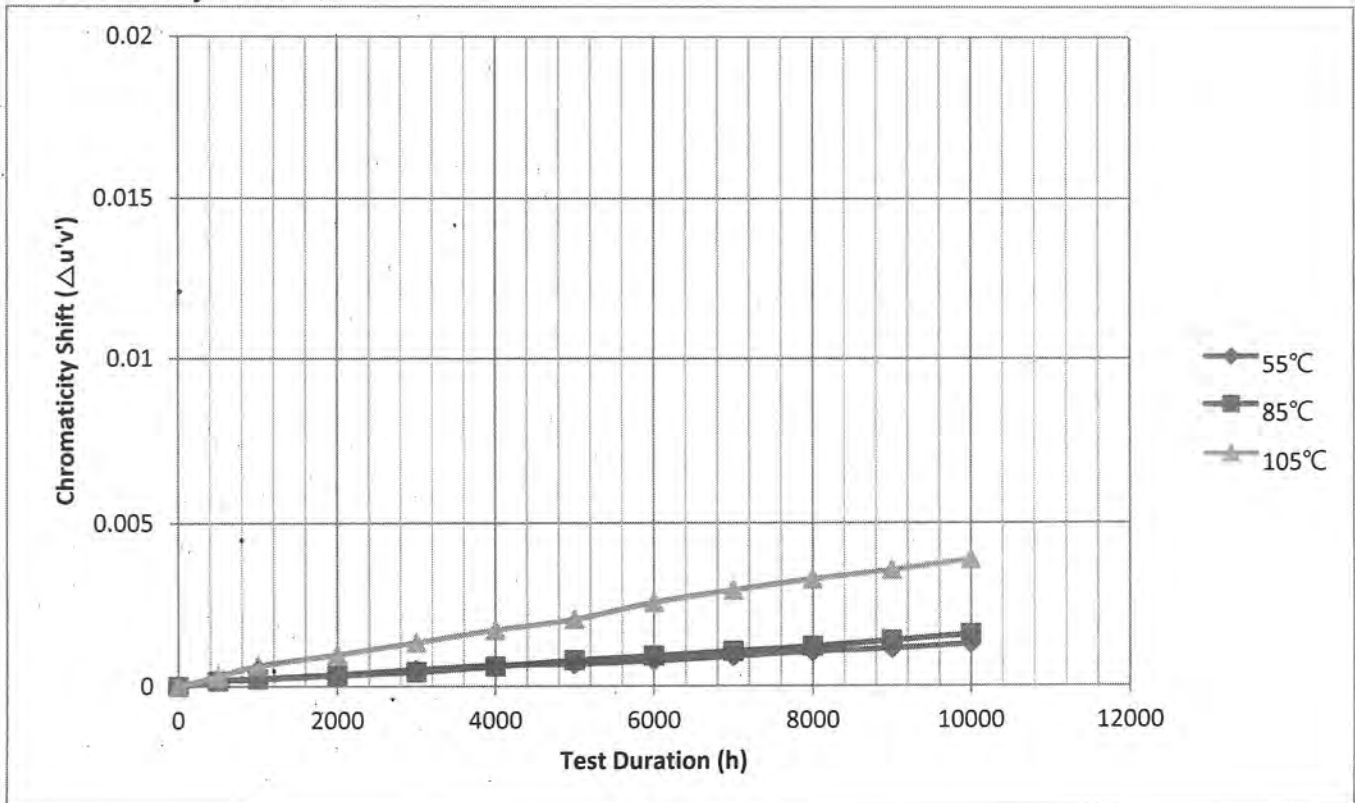
See the table

9.4 Chart

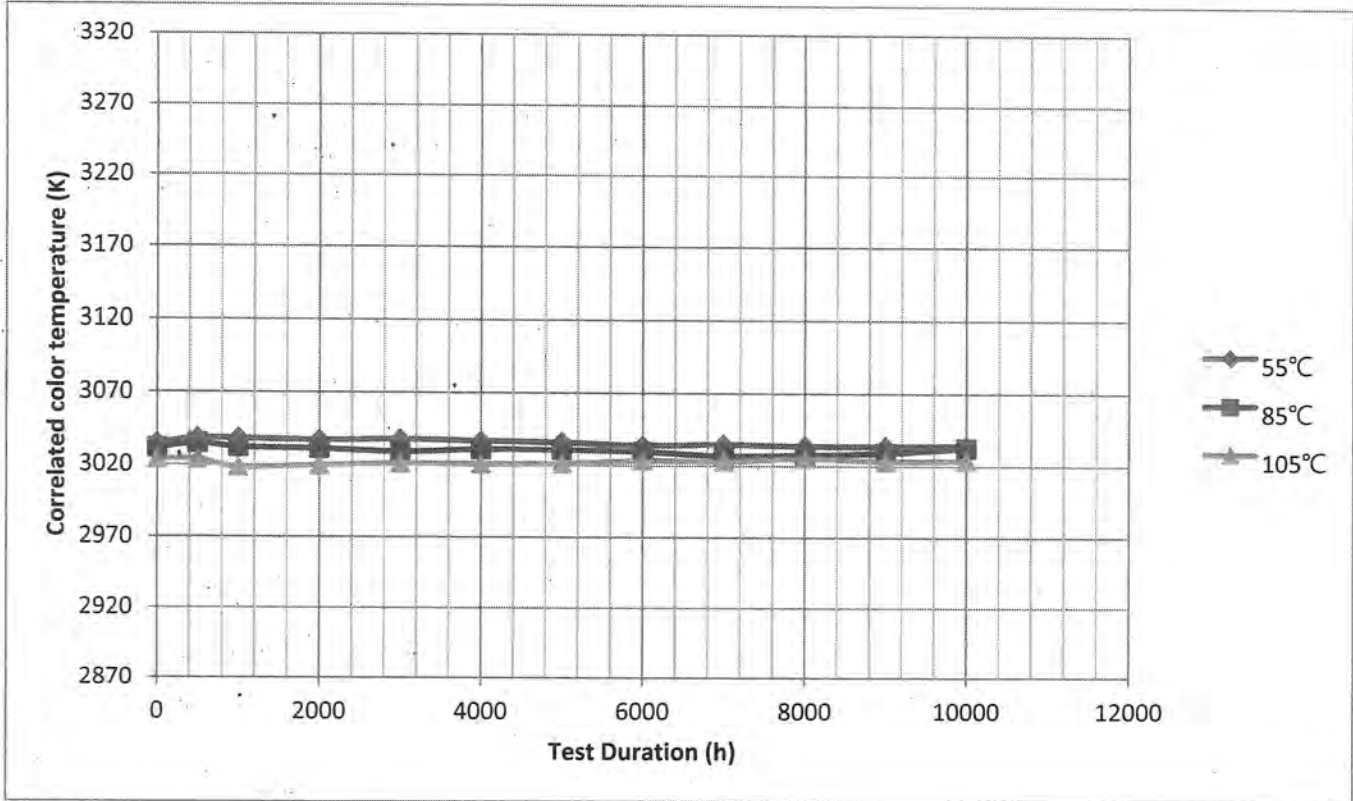
<Lumen Maintenance>



<Chromaticity Shift>



<CCT>



10. Observation of failures

No optical, Electrical or mechanical failure of any LED Package was seen during the lifetime testing.

11. LED light source monitoring interval

0 500 1 000 2 000 3 000 4 000 5 000 6 000 7 000 8 000
9 000 10 000

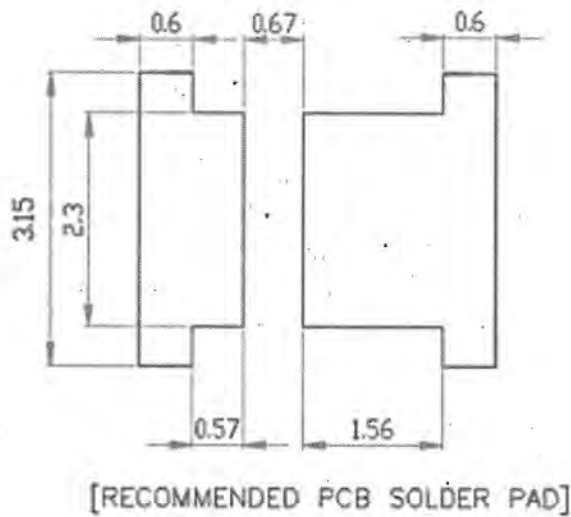
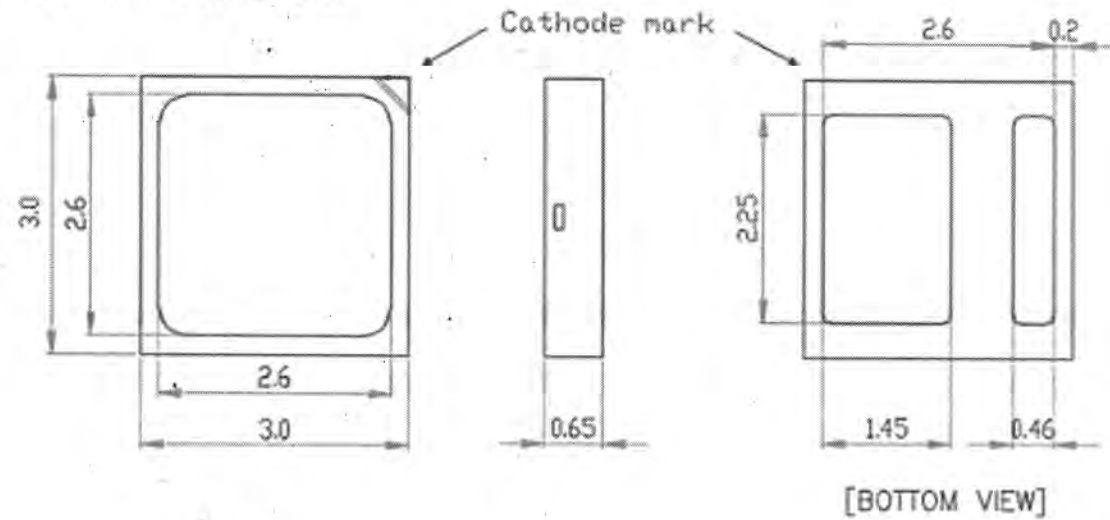
12. Photometric measurement uncertainty

3.5%

13. TM-21-11 Report : Projecting Long Term Lumen Maintenance of LED Light Source

Table 1: Report at each LM-80 Test Condition							
Description of LED Light Source Tested (manufacturer, model, catalog number)		Test Condition 1 - 55°C Case Temp		Test Condition 2 - 85°C Case Temp		Test Condition 3 - 105°C Case Temp	
Sample size	20	Sample size	20	Sample size	20	Sample size	20
Number of failures	0	Number of failures	0	Number of failures	0	Number of failures	0
DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150
Test duration (hours)	10,000	Test duration (hours)	10,000	Test duration (hours)	10,000	Test duration (hours)	10,000
Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000
Tested case temperature (°C)	55	Tested case temperature (°C)	85	Tested case temperature (°C)	105	Tested case temperature (°C)	105
α	2.285E-06	α	2.445E-06	α	6.272E-06	α	6.272E-06
B	0.992	B	0.988	B	0.993	B	0.993
Reported L90(10k) (hours)	43,000	Reported L90(10k) (hours)	38,000	Reported L90(10k) (hours)	16,000	Reported L90(10k) (hours)	16,000

14. Dimension of samples



Measurement unit : mm

Tolerance : $\pm 0.1\text{mm}$

15. Cover models

*******END OF TEST REPORT*******